

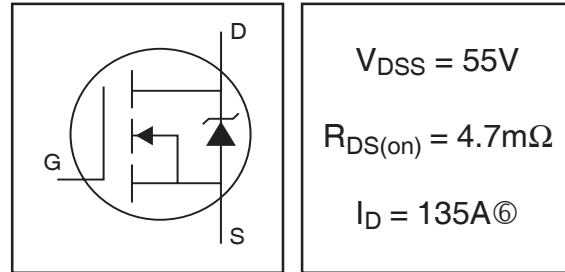
**Typical Applications**

- Industrial Motor Drive

HEXFET® Power MOSFET

**Features**

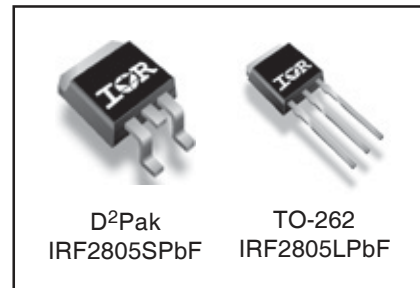
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free



$V_{DS} = 55V$   
 $R_{DS(on)} = 4.7m\Omega$   
 $I_D = 135A\text{⑥}$

**Description**

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this product are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in a wide variety of applications.



D²Pak TO-262  
IRF2805SPbF IRF2805LPbF

**Absolute Maximum Ratings**

|                            | Parameter                                   | Max.                     | Units |
|----------------------------|---|--------------------------|-------|
| $I_D @ T_C = 25^\circ C$   | Continuous Drain Current, $V_{GS} @ 10V$    | 135⑥                     | A     |
| $I_D @ T_C = 100^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V$    | 96⑥                      |       |
| $I_{DM}$                   | Pulsed Drain Current ①                      | 700                      |       |
| $P_D @ T_C = 25^\circ C$   | Power Dissipation                           | 200                      | W     |
|                            | Linear Derating Factor                      | 1.3                      | W/°C  |
| $V_{GS}$                   | Gate-to-Source Voltage                      | $\pm 20$                 | V     |
| $E_{AS}$                   | Single Pulse Avalanche Energy②              | 380                      | mJ    |
| $E_{AS} (6 \text{ sigma})$ | Single Pulse Avalanche Energy Tested Value⑧ | 1220                     |       |
| $I_{AR}$                   | Avalanche Current⑩                          | See Fig.12a, 12b, 15, 16 | A     |
| $E_{AR}$                   | Repetitive Avalanche Energy⑦                |                          | mJ    |
| $dv/dt$                    | Peak Diode Recovery $dv/dt$ ③               | 2.0                      | V/ns  |
| $T_J$                      | Operating Junction and                      | -55 to + 175             | °C    |
| $T_{STG}$                  | Storage Temperature Range                   |                          |       |
|                            | Soldering Temperature, for 10 seconds       | 300 (1.6mm from case )   |       |

**Thermal Resistance**

|                 | Parameter  | Typ. | Max. | Units |
|-----------------|--|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                                 | —    | 0.75 | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient(PCB Mounted, steady state)** | —    | 40   |       |

HEXFET(R) is a registered trademark of International Rectifier.

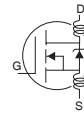
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# IRF2805S/LPbF

International  
**IR** Rectifier

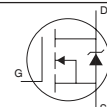
## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ. | Max. | Units | Conditions  |
|---------------------------------|--------------------------------------|------|------|------|-------|---|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 55   | —    | —    | V     | $V_{GS} = 0V, I_D = 250\mu A$   |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.06 | —    | V/°C  | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$                           |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 3.9  | 4.7  | mΩ    | $V_{GS} = 10V, I_D = 104A$ ④  |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —    | 4.0  | V     | $V_{DS} = 10V, I_D = 250\mu A$  |
| $g_{fs}$                        | Forward Transconductance             | 91   | —    | —    | S     | $V_{DS} = 25V, I_D = 104A$  |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 20   | μA    | $V_{DS} = 55V, V_{GS} = 0V$   |
|                                 |                                      | —    | —    | 250  |       | $V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$                        |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 200  | nA    | $V_{GS} = 20V$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -200 |       | $V_{GS} = -20V$   |
| $Q_g$                           | Total Gate Charge                    | —    | 150  | 230  | nC    | $I_D = 104A$  |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | 38   | 57   |       | $V_{DS} = 44V$  |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | 52   | 78   |       | $V_{GS} = 10V$ ④  |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 14   | —    | ns    | $V_{DD} = 28V$  |
| $t_r$                           | Rise Time                            | —    | 120  | —    |       | $I_D = 104A$  |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 68   | —    |       | $R_G = 2.5\Omega$   |
| $t_f$                           | Fall Time                            | —    | 110  | —    |       | $V_{GS} = 10V$ ④  |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5  | —    | nH    | Between lead,<br>6mm (0.25in.)<br>from package<br>and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 7.5  | —    |       |   |
| $C_{iss}$                       | Input Capacitance                    | —    | 5110 | —    | pF    | $V_{GS} = 0V$   |
| $C_{oss}$                       | Output Capacitance                   | —    | 1190 | —    |       | $V_{DS} = 25V$  |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 210  | —    |       | $f = 1.0\text{MHz}$ , See Fig. 5  |
| $C_{oss}$                       | Output Capacitance                   | —    | 6470 | —    |       | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$                             |
| $C_{oss}$                       | Output Capacitance                   | —    | 860  | —    |       | $V_{GS} = 0V, V_{DS} = 44V, f = 1.0\text{MHz}$                              |
| $C_{oss\ eff.}$                 | Effective Output Capacitance ⑤       | —    | 1600 | —    |       | $V_{GS} = 0V, V_{DS} = 0V$ to 44V   |



## Source-Drain Ratings and Characteristics

|          | Parameter                                 | Min.  | Typ. | Max. | Units | Conditions  |
|----------|---|---|------|------|-------|---|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —   | —    | 175⑥ | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①   | —   | —    | 700  |       |   |
| $V_{SD}$ | Diode Forward Voltage                     | —   | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 104A, V_{GS} = 0V$ ④                     |
| $t_{rr}$ | Reverse Recovery Time                     | —   | 80   | 120  | ns    | $T_J = 25^\circ\text{C}, I_F = 104A$                                    |
| $Q_{rr}$ | Reverse Recovery Charge                   | —   | 290  | 430  | nC    | $di/dt = 100A/\mu s$ ④  |
| $t_{on}$ | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |       |   |



### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Starting  $T_J = 25^\circ\text{C}, L = 0.08\text{mH}$   
 $R_G = 25\Omega, I_{AS} = 104A$ . (See Figure 12).
- ③  $I_{SD} \leq 104A, di/dt \leq 240A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 400\mu s$ ; duty cycle  $\leq 2\%$ .

- ⑤  $C_{oss\ eff.}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑥ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ⑦ Limited by  $T_{Jmax}$ , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑧ This value determined from sample failure population. 100% tested to this value in production.

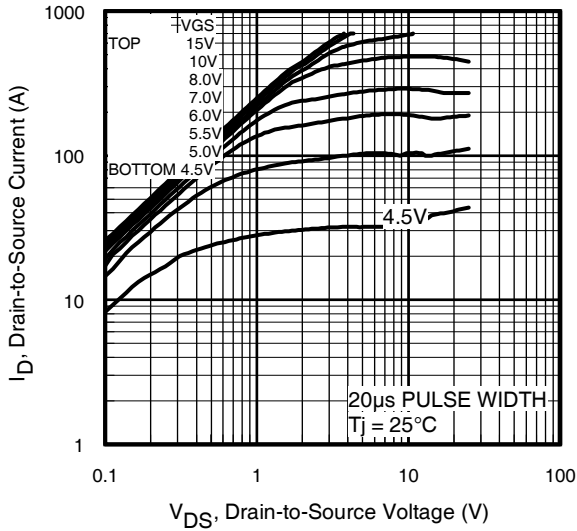


Fig 1. Typical Output Characteristics

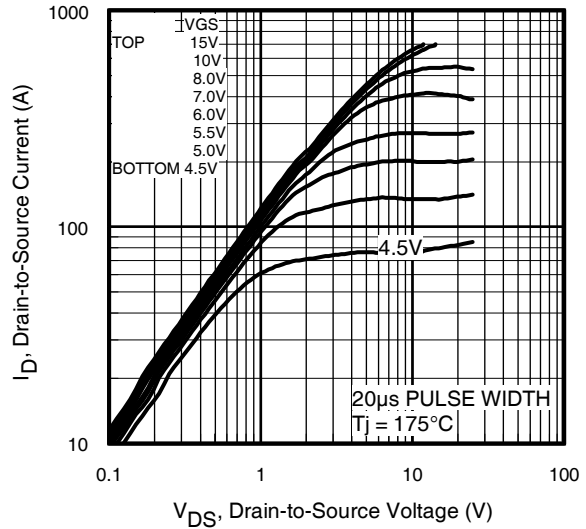


Fig 2. Typical Output Characteristics

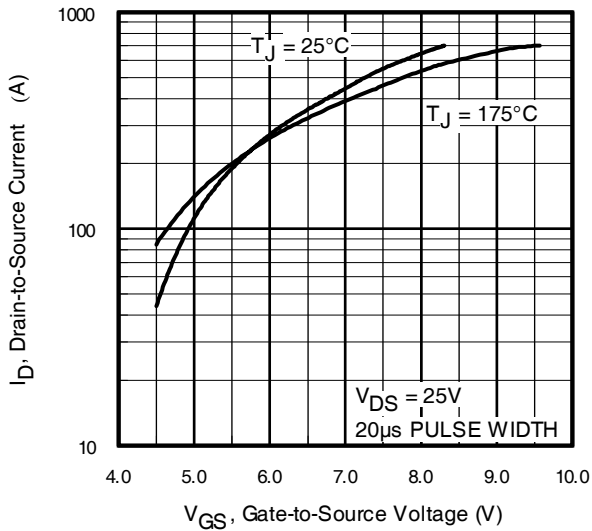


Fig 3. Typical Transfer Characteristics

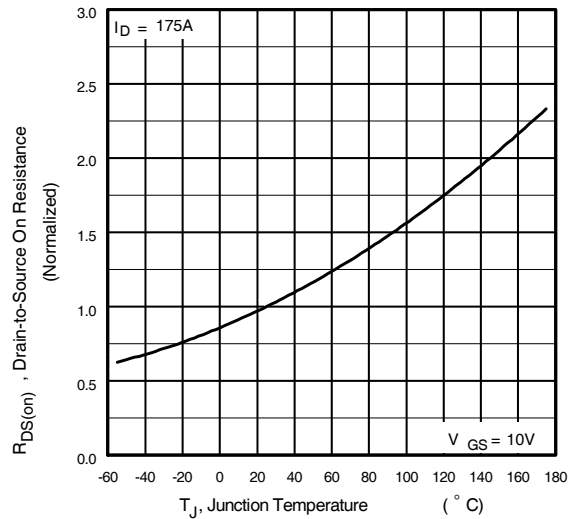
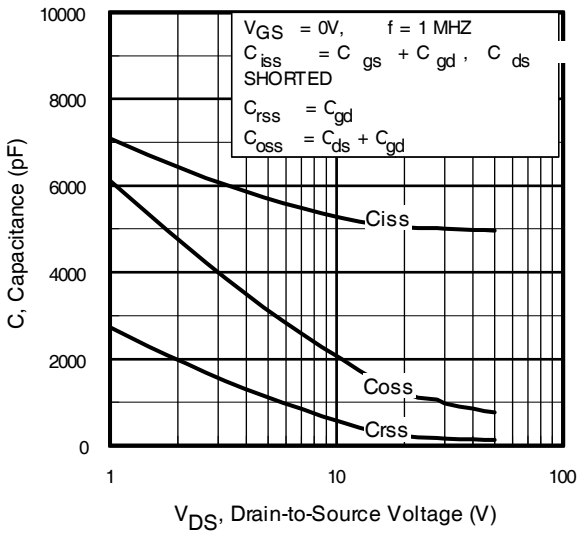
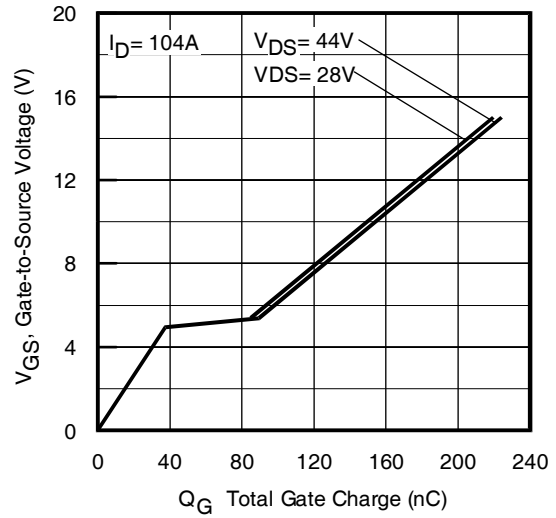


Fig 4. Normalized On-Resistance Vs. Temperature

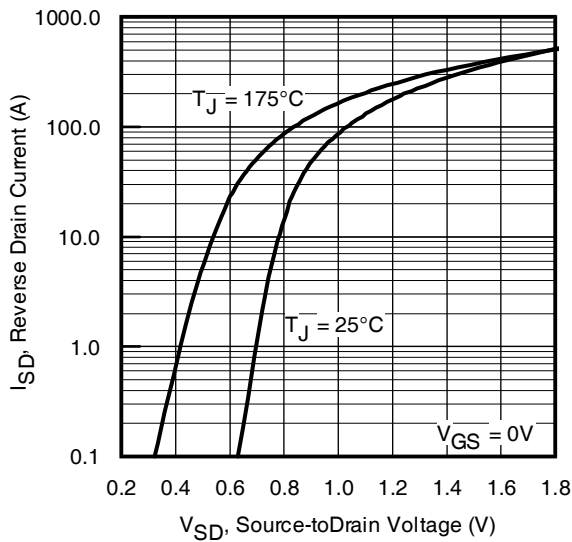
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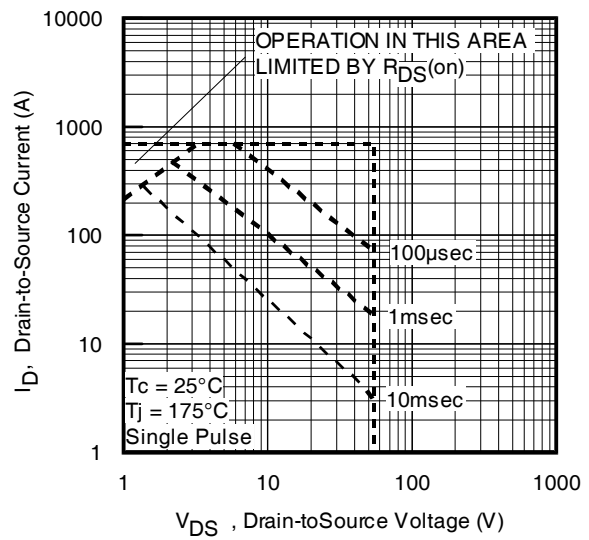
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



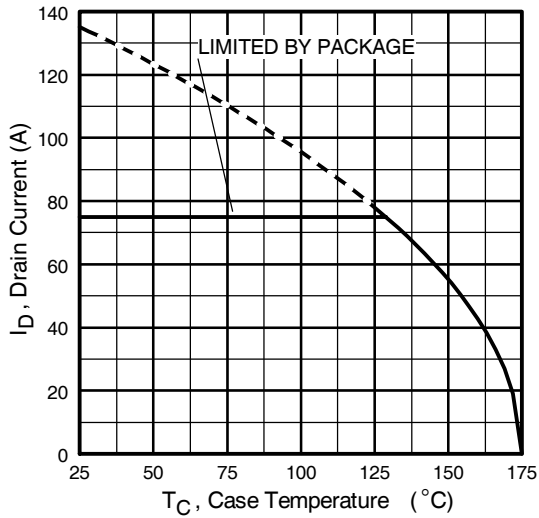
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



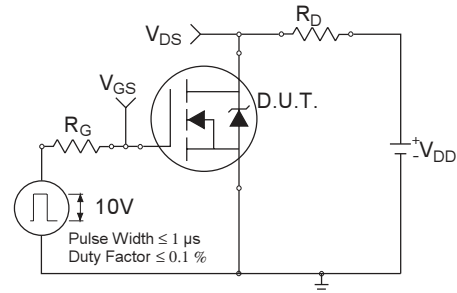
**Fig 7.** Typical Source-Drain Diode Forward Voltage



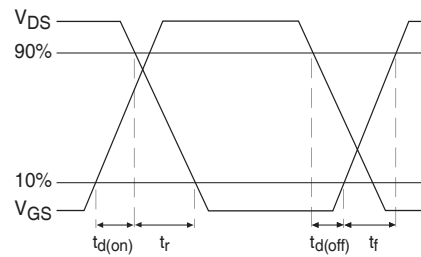
**Fig 8.** Maximum Safe Operating Area



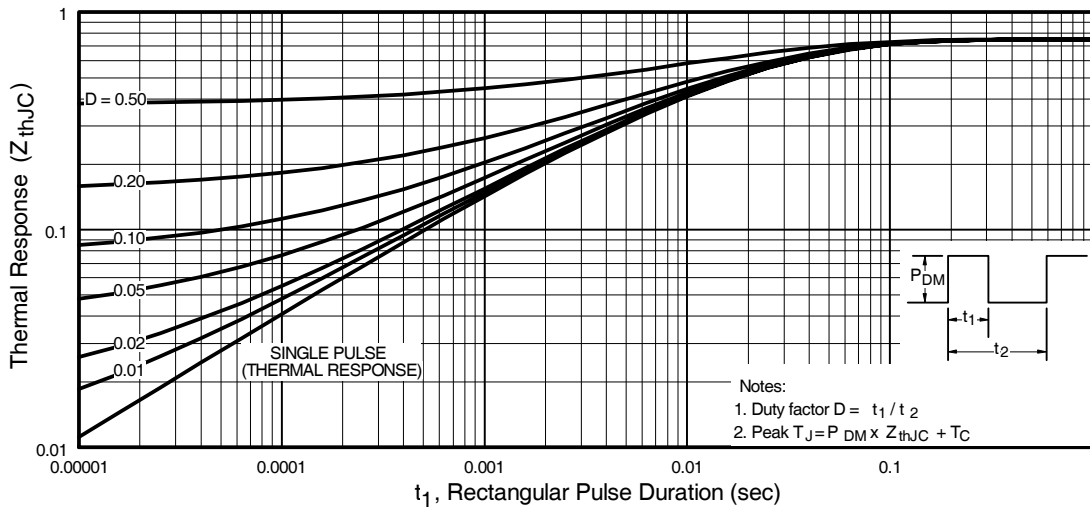
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



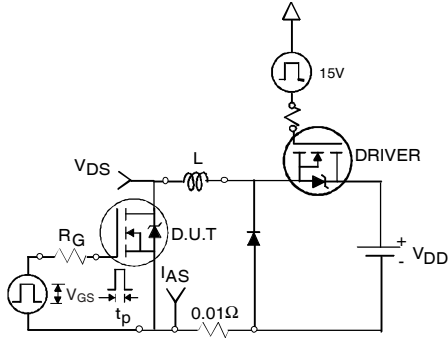
**Fig 10b.** Switching Time Waveforms



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRF2805S/LPbF

International  
**IR** Rectifier



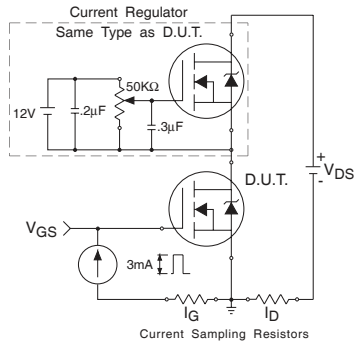
**Fig 12a.** Unclamped Inductive Test Circuit



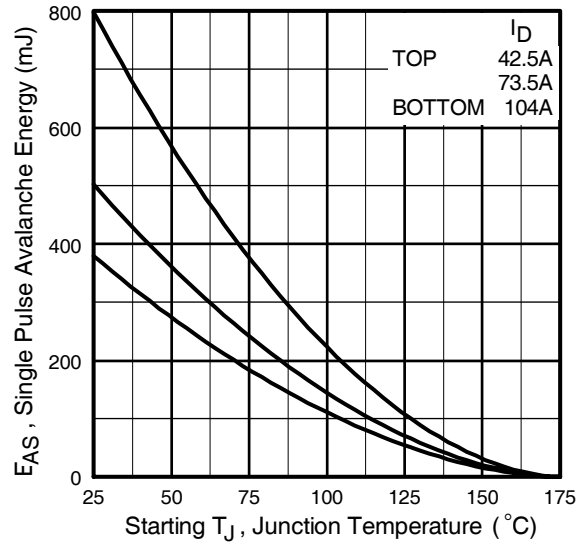
**Fig 12b.** Unclamped Inductive Waveforms



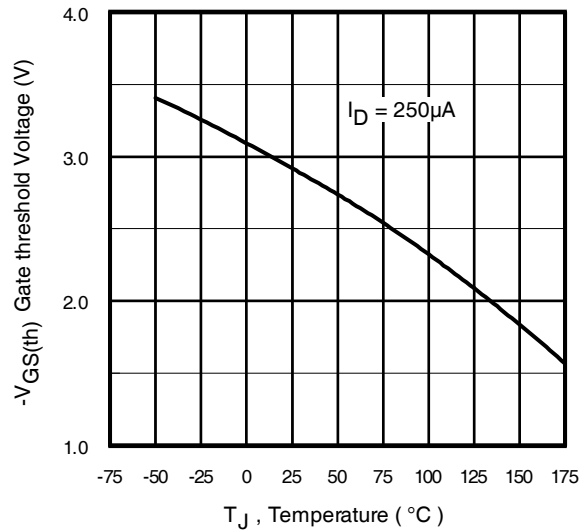
**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 14.** Threshold Voltage Vs. Temperature

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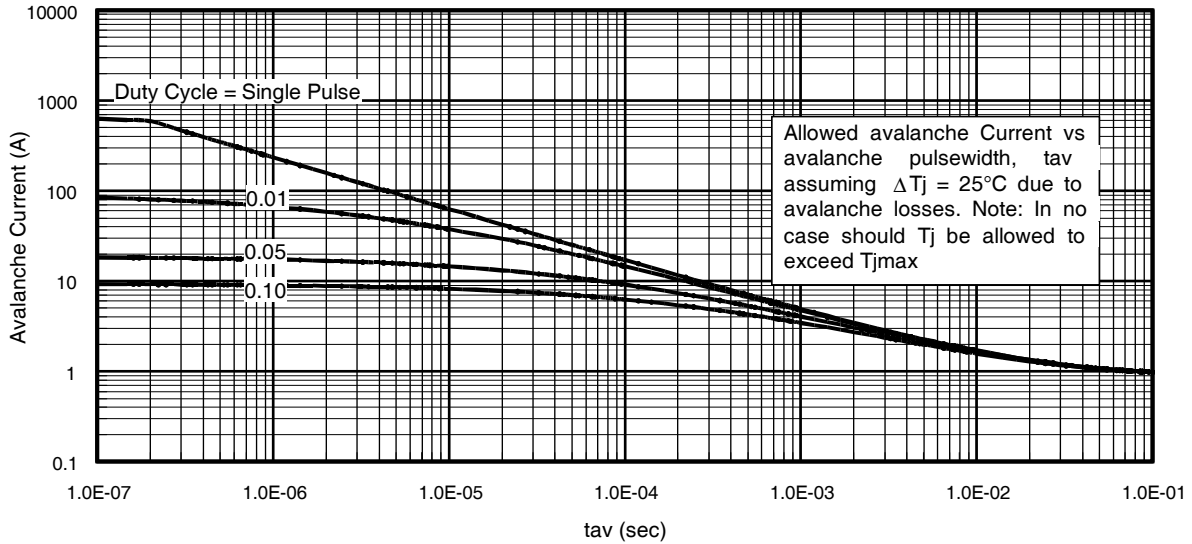


Fig 15. Typical Avalanche Current Vs.Pulsewidth

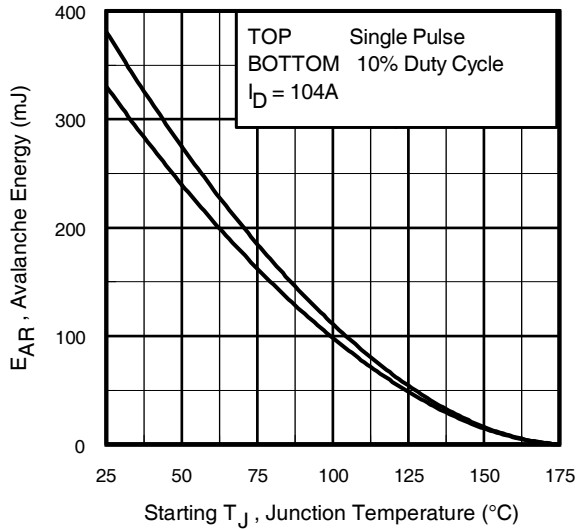


Fig 16. Maximum Avalanche Energy Vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:  
(For further info, see AN-1005 at www.irf.com)**

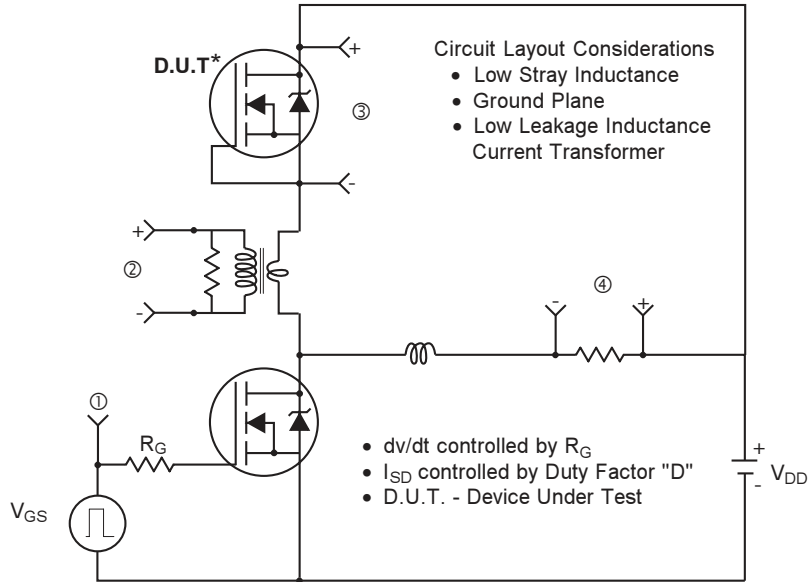
1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  
 $t_{av}$  = Average time in avalanche.  
D = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

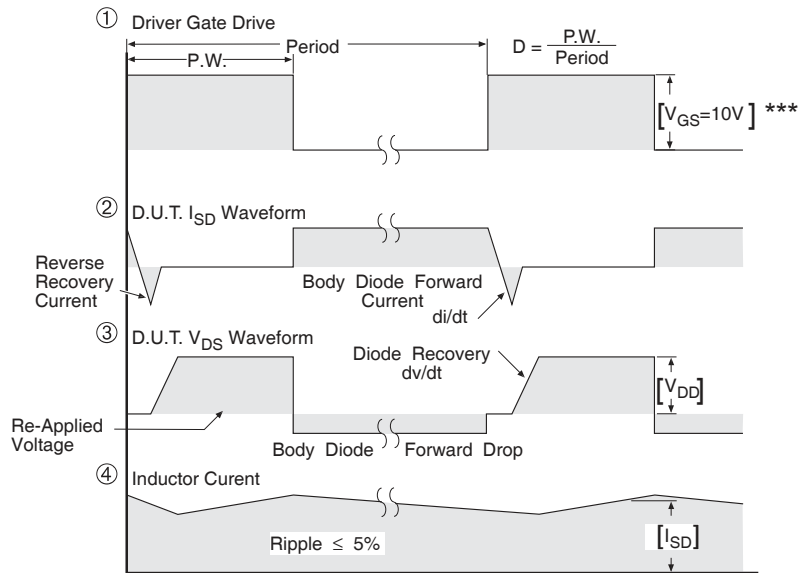
$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

## Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity of D.U.T for P-Channel



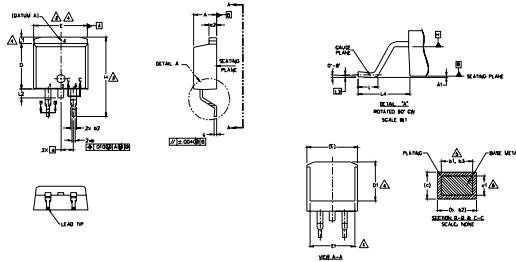
\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

**Fig 17.** For N-channel HEXFET® power MOSFETs



## D<sup>2</sup>Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)



**LEAD ASSIGNMENTS**

- DIODES**
- 1.- ANODE (TWO DIE) / OPEN (ONE DIE)
  - 2, 4.- CATHODE
  - 3.- ANODE
- HEXFET**
- 1.- GATE
  - 2, 4.- DRAIN
  - 3.- SOURCE
- IGBTs, CoPACK**
- 1.- GATE
  - 2, 4.- COLLECTOR
  - 3.- EMITTER

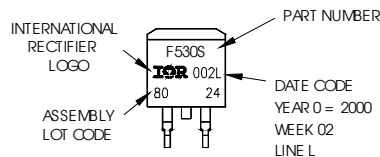
| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 4.06        | 4.83  | .160     | .190 |       |
| A1     | 0.00        | 0.254 | .000     | .010 |       |
| b      | 0.51        | 0.99  | .020     | .039 |       |
| b1     | 0.51        | 0.89  | .020     | .035 | 5     |
| b2     | 1.14        | 1.78  | .045     | .070 |       |
| b3     | 1.14        | 1.73  | .045     | .068 | 5     |
| c      | 0.38        | 0.74  | .015     | .029 |       |
| c1     | 0.38        | 0.58  | .015     | .023 | 5     |
| c2     | 1.14        | 1.65  | .045     | .065 |       |
| D      | 8.38        | 9.65  | .330     | .380 | 3     |
| D1     | 6.86        | -     | .270     | -    | 4     |
| E      | 9.65        | 10.67 | .380     | .420 | 3,4   |
| E1     | 6.22        | -     | .245     | -    | 4     |
| e      | 2.54 BSC    |       | .100 BSC |      |       |
| H      | 14.61       | 15.88 | .575     | .625 |       |
| L      | 1.78        | 2.79  | .070     | .110 |       |
| L1     | -           | 1.65  | -        | .066 | 4     |
| L2     | -           | 1.78  | -        | .070 |       |
| L3     | 0.25 BSC    |       | .010 BSC |      |       |
| L4     | 4.78        | 5.28  | .188     | .208 |       |

- NOTES:**
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
  - DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
  - DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
  - THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
  - DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
  - DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
  - CONTROLLING DIMENSION: INCH.
  - OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

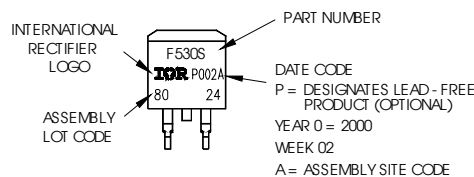
## D<sup>2</sup>Pak (TO-263AB) Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH  
LOT CODE 8024  
ASSEMBLED ON WW02, 2000  
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position  
indicates "Lead - Free"



OR



**Notes:**

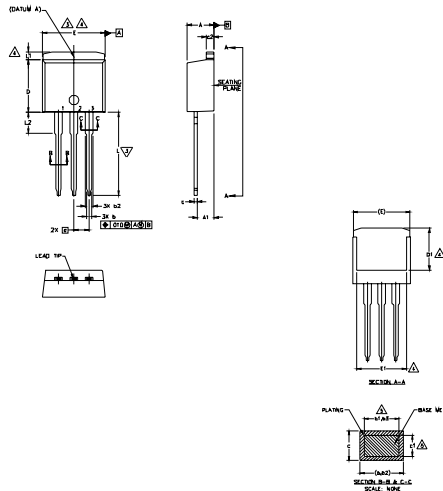
- For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/auto/>
- For the most current drawing please refer to IR website at <http://www.irf.com/package/>

# IRF2805S/LPbF



## TO-262 Package Outline

Dimensions are shown in millimeters (inches)



**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. CONTROLLING DIMENSION: INCH.
7. OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 4.06        | 4.83  | .160     | .190 | 5     |
| A1     | 2.03        | 3.02  | .080     | .119 |       |
| b      | 0.51        | 0.99  | .020     | .039 |       |
| b1     | 0.51        | 0.89  | .020     | .035 |       |
| b2     | 1.14        | 1.78  | .045     | .070 |       |
| b3     | 1.14        | 1.73  | .045     | .068 | 5     |
| c      | 0.38        | 0.74  | .015     | .029 | 5     |
| c1     | 0.38        | 0.58  | .015     | .023 |       |
| c2     | 1.14        | 1.65  | .045     | .065 | 3     |
| D      | 8.38        | 9.65  | .330     | .380 |       |
| D1     | 6.86        | -     | .270     | -    | 4     |
| E      | 9.65        | 10.67 | .380     | .420 | 3,4   |
| E1     | 6.22        | -     | .245     | -    | 4     |
| e      | 2.54 BSC    |       | .100 BSC |      | 4     |
| L      | 13.46       | 14.10 | .530     | .555 |       |
| L1     | -           | 1.65  | -        | .065 |       |
| L2     | 3.56        | 3.71  | .140     | .146 |       |

**LEAD ASSIGNMENTS**

**HEXFET**

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

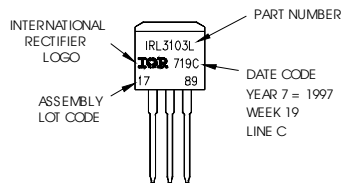
**IGBTs, CoPACK**

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

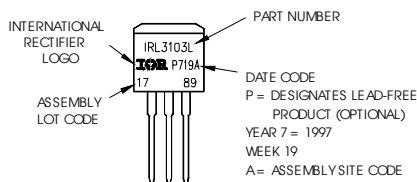
## TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"



OR

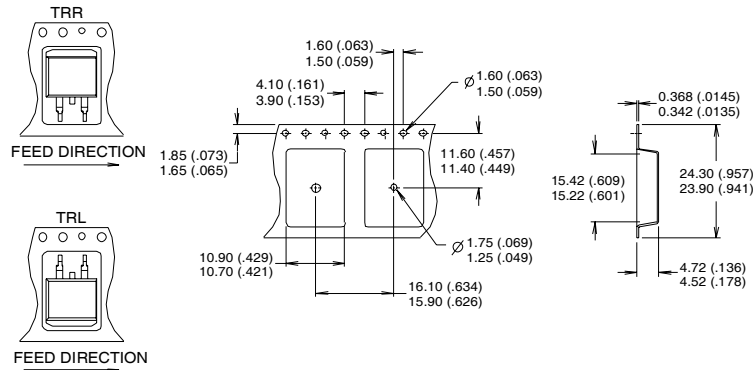


**Notes:**

1. For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/aut/>
2. For the most current drawing please refer to IR website at <http://www.irf.com/package/>

## D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES:
1. CONFORMS TO EIA-418.
  2. CONTROLLING DIMENSION: MILLIMETER.
  3. DIMENSION MEASURED @ HUB.
  4. INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

## **IMPORTANT NOTICE**

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